

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/609,192	TAN ET AL.	
		Examiner	Art Unit	
		Jacob Cheu	1641	Page 1 of 1

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*	A	US-5,795,734	08-1998	Flanagan et al.	435/69.1
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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